

**PATENT**

**IN THE UNITED STATES PATENT OFFICE**

Serial No.: 10/067,061

Filed: February 4, 2002

For: Method of Efficiently Converting-to-Array  
And Compressing Data in a Process for  
Converting Mask Patterns of a LSI

Inventors: Keiji Yoshizawa

Examiner: Do, Anh Hong

Art Unit: 2624

Atty. Doc. No.: 023-02

---

**INFORMATION DISCLOSURE STATEMENT**

Mail Stop RCE  
Commissioner For Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In the interest of full disclosure, the following items are herewith identified in Form PTO-1449 and a copy of the same is hereby provided, for the convenience of the U.S. Patent and Trademark Office.

This Information Disclosure Statement is being filed together with an RCE for the purposes of continued examination based on additional prior art.

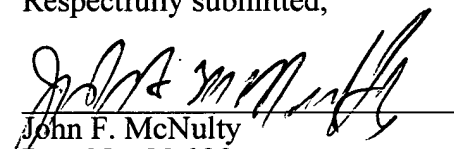
**FOREIGN PATENTS**

(AA) JP 05342306, December 24, 1993, Miyauchi Toru. Relevance is in the English abstract and the partial English translation attached hereto.

(AB) JP 09128421, May 16, 1997, Robaato Fuerutoman, et al. Relevance is in the English abstract and the partial English translation attached hereto.

(AC) JP 2002092064, March 29, 2002, Ueki Shinichi. Relevance is in the English abstract and the partial English translation attached hereto.

Respectfully submitted,

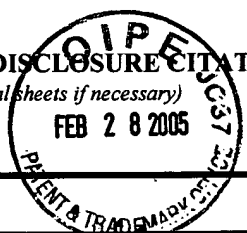


John F. McNulty  
Reg. No. 23,028  
Attorney for Applicants  
Paul & Paul  
2900 Two Thousand Market St.  
Philadelphia, PA 19103  
(215) 568-4900

# INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

FEB 28 2005



Docket Number (Optional)

023-02

Application Number

10/067,061

Applicant(s)

Keiji Yoshizawa

Filing Date

February 4, 2002

Group Art Unit

2624

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

## FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
	AA	JP 05342306	12/24/93	Japan				
	AB	JP 09128421	05/16/97	Japan				
	AC	2002092064	03/29/02	Japan				

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.